

Signal formation in Vertical Drift

DUNE – France Analysis workshop

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Vertical drift design

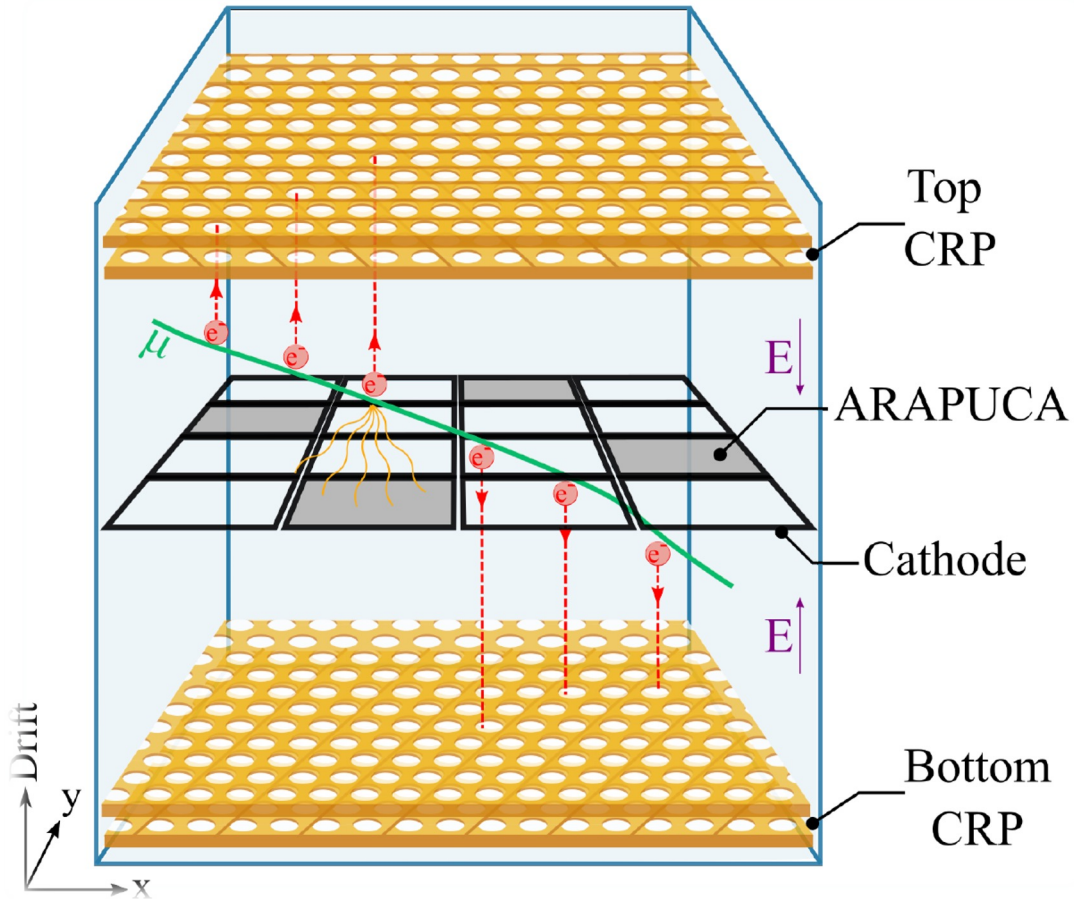


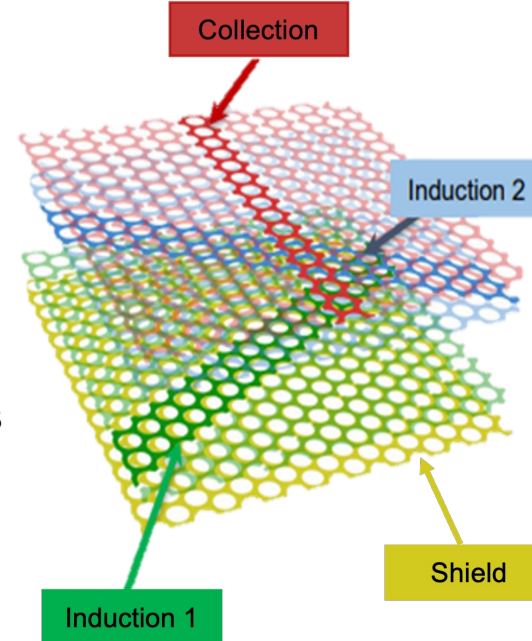
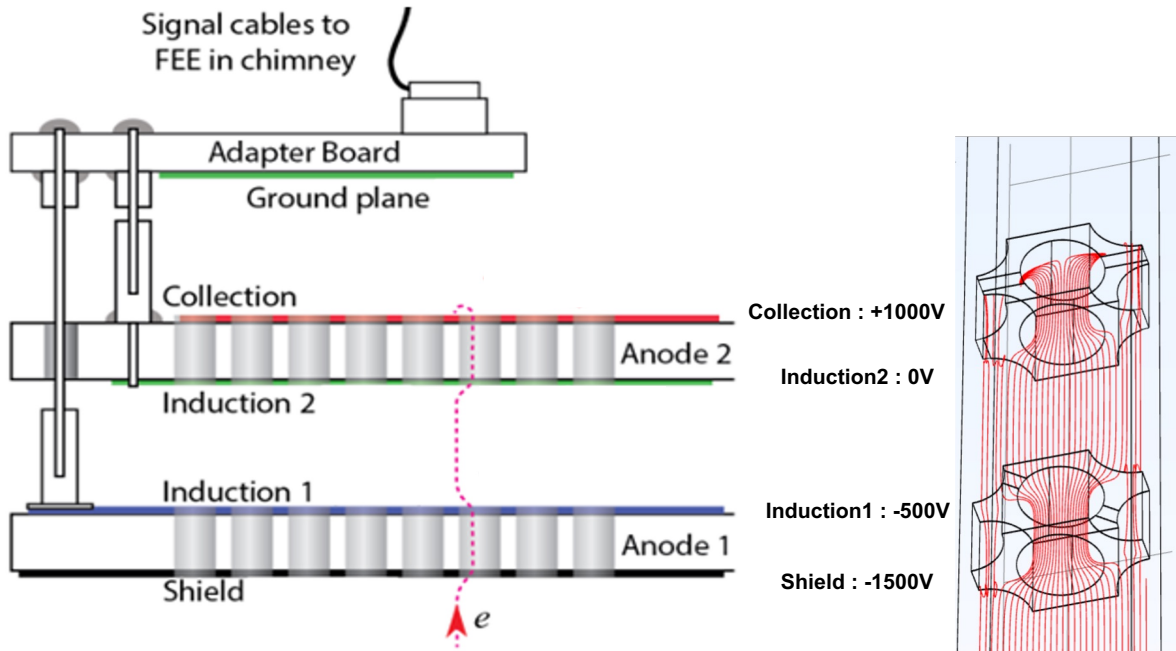
Diagram by L. Zambelli

- 2 volumes split by a cathode
 - Electric drift field: $|\vec{E}| = 0.5 \text{ kV/cm}$
- X-ARAPUCA* for light detection on the cathode
- The new perforated anode technology
 - Stack of 2 perforated Printed Circuit Boards (PCB)
 - Etched copper electrode strips on each PCB face
 - A sub-centimeter spatial resolution
 - Module called Charge-Readout Planes (CRP) $\sim 3 \times 3 \text{ m}$
- DUNE Far detector at SURF:
 - 80 module CRPs for each top and bottom TPC
 - Half will be produced at Grenoble

* Light detector device

The perforated anode technology

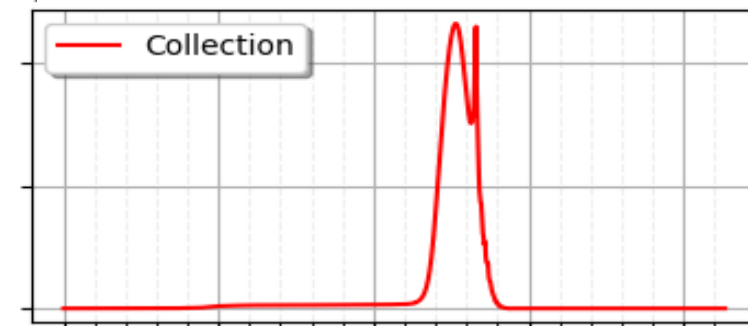
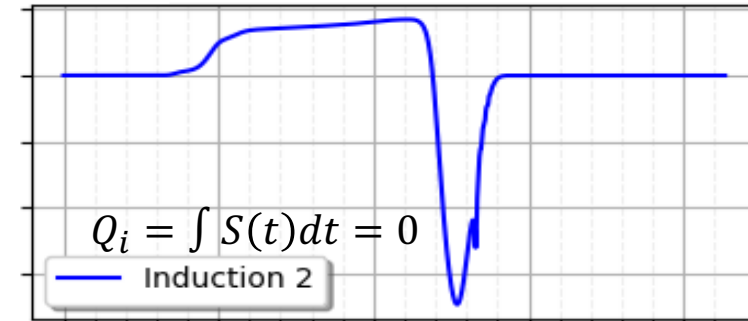
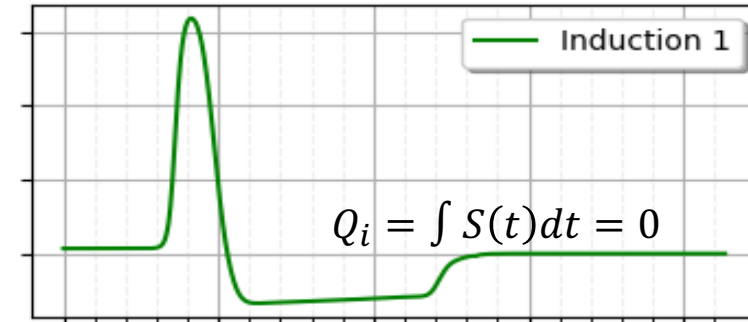
- Shield + 3 different charge readout layers:
 - **Induction 1 (view 0)** – strip orientation -30° wrt beam axis
 - **Induction 2 (view 1)** – strip orientation $+30^\circ$ wrt beam axis
 - **Collection (view 2)** – strip orientation 90° wrt beam axis



- **Induction views:** Bipolar signals
- **Collection view:** Unipolar signal

$$Q_{coll} = \int S(t)dt = N_e \times e$$

➤ Signal before convolution



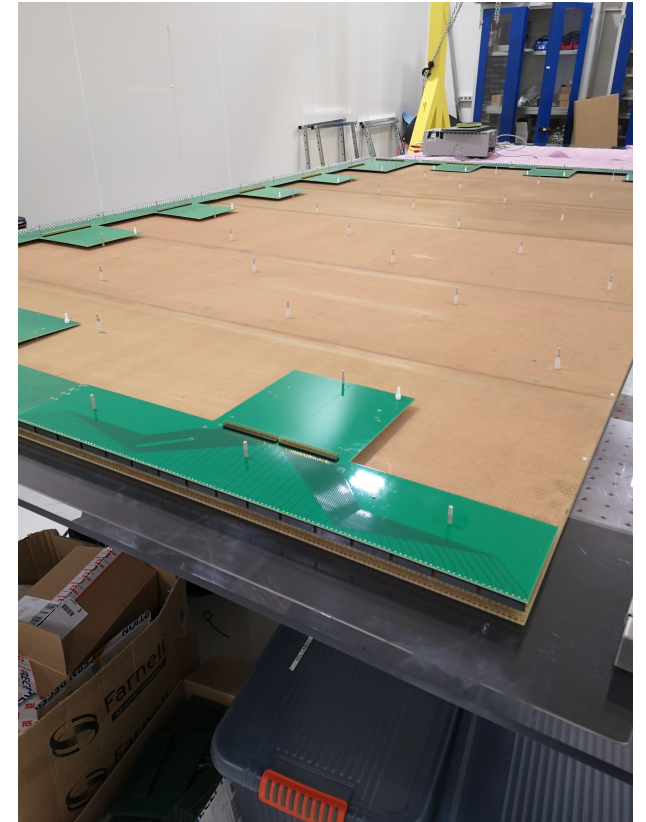
Signal formation study on anodes

- **Problematic:**

- Use of new anode technology
- Important to know the deposited energy in the detector to measure the neutrino oscillation parameters
- Important to reconstruct the particle tracks from collected charge

- **My work:**

- Understanding the waveforms based on energy, track angle and position
- Understanding the charge lost in the anodes
- Estimate the different systematics
- **Study of induced signal formation on the anode**



CRP assembly at
CERN

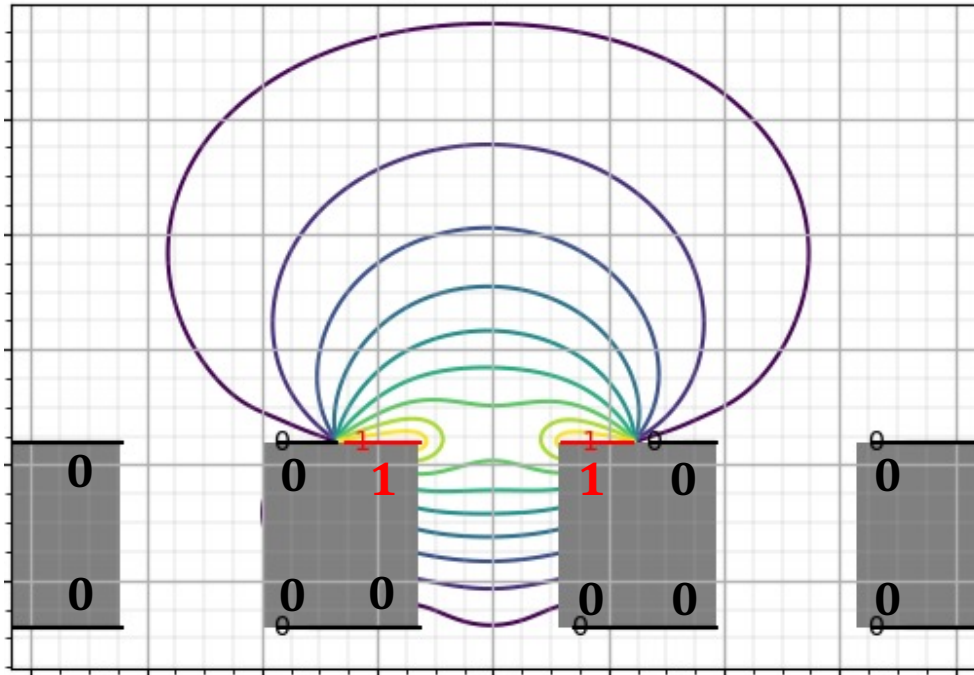
Modeling signal formation

➤ Shockley-Ramo theorem:

$$i(t) = q \vec{E}_w \cdot \vec{v}_D$$

- Weighting Field \vec{E}_w is virtual field defined when the reading strip equal 1 V and all others fixed to 0 V

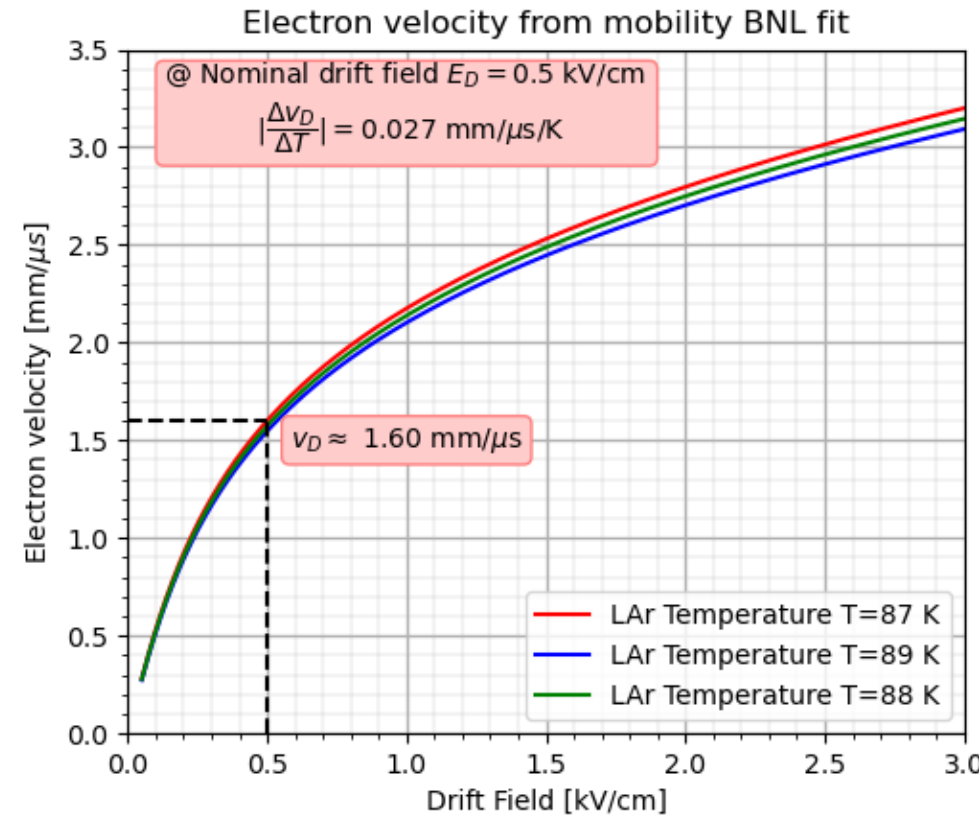
Weighting Potential



$\left\{ \begin{array}{l} \vec{E}_w: \text{ geometry factor} \\ \vec{v}_D: \text{ physics factor} \end{array} \right.$

➤ Drift velocity:

$$\vec{v}_D \equiv \vec{v}_D(\vec{E}_D, T)$$



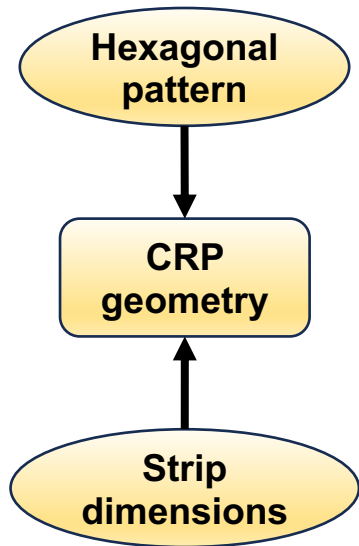
- The instantaneous current is induced by charge motion only

- Need simulation for complex geometry

<https://lar.bnl.gov/properties/trans.html>

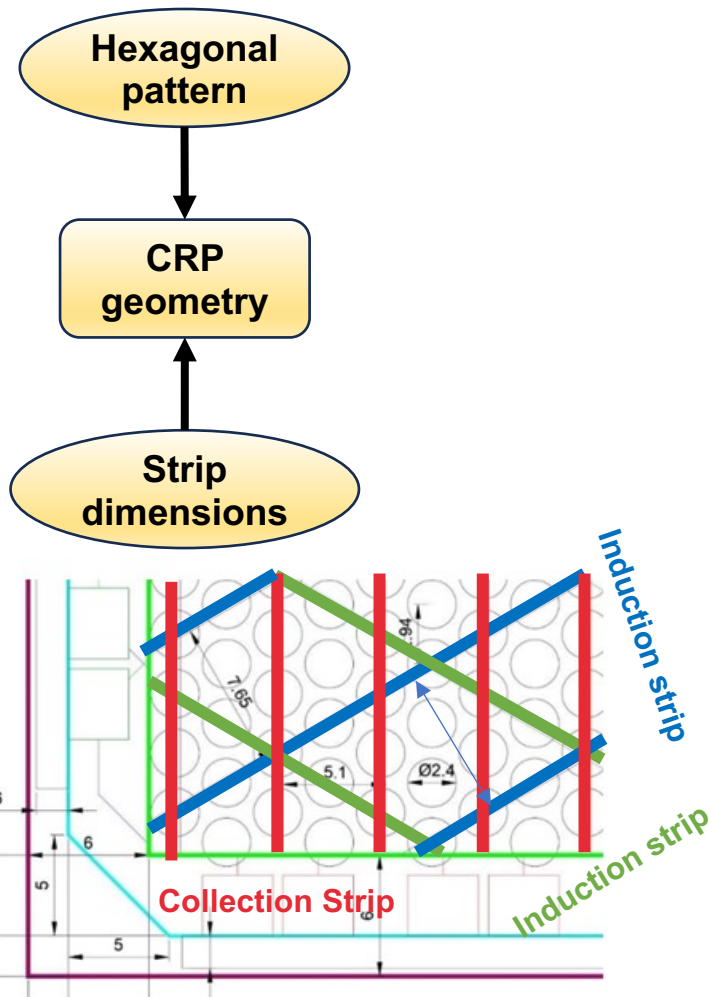
Induced signal simulation

- Design of a simulation on Python

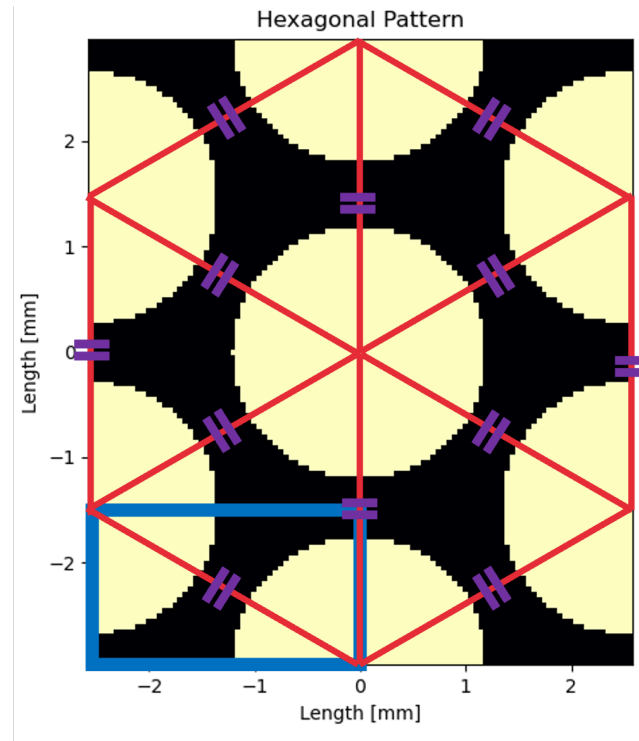


Induced signal simulation

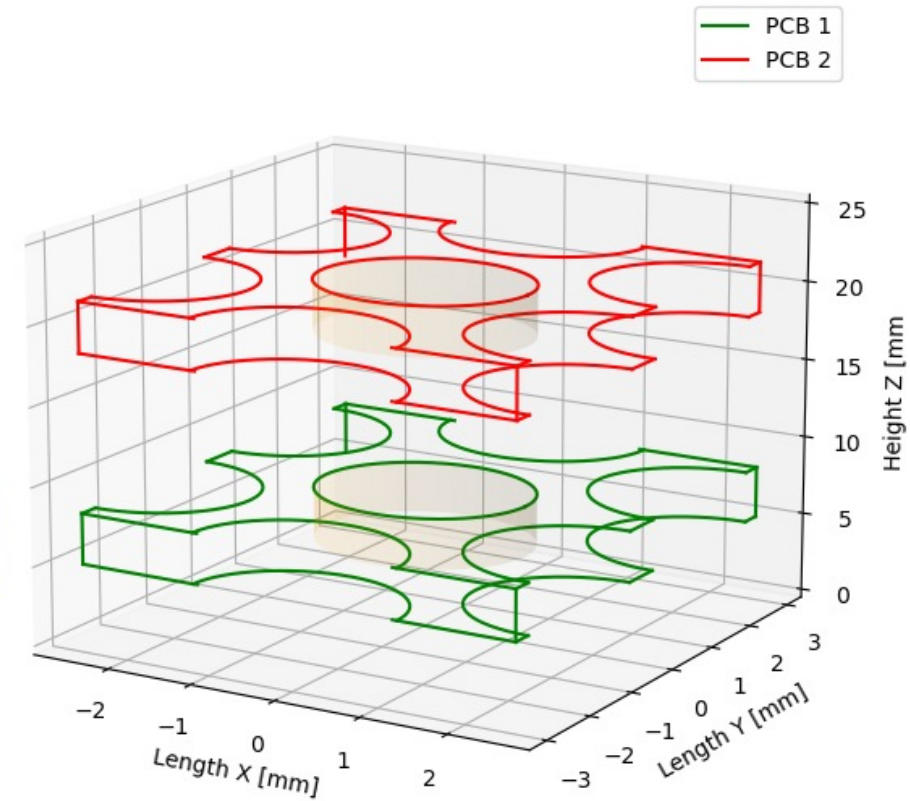
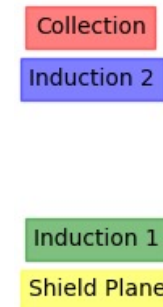
- Numerical simulation on Python



- Implement CRP geometry hexagonal pattern, width strips, 2 Printed Circuit Boards, 4 equipotential planes

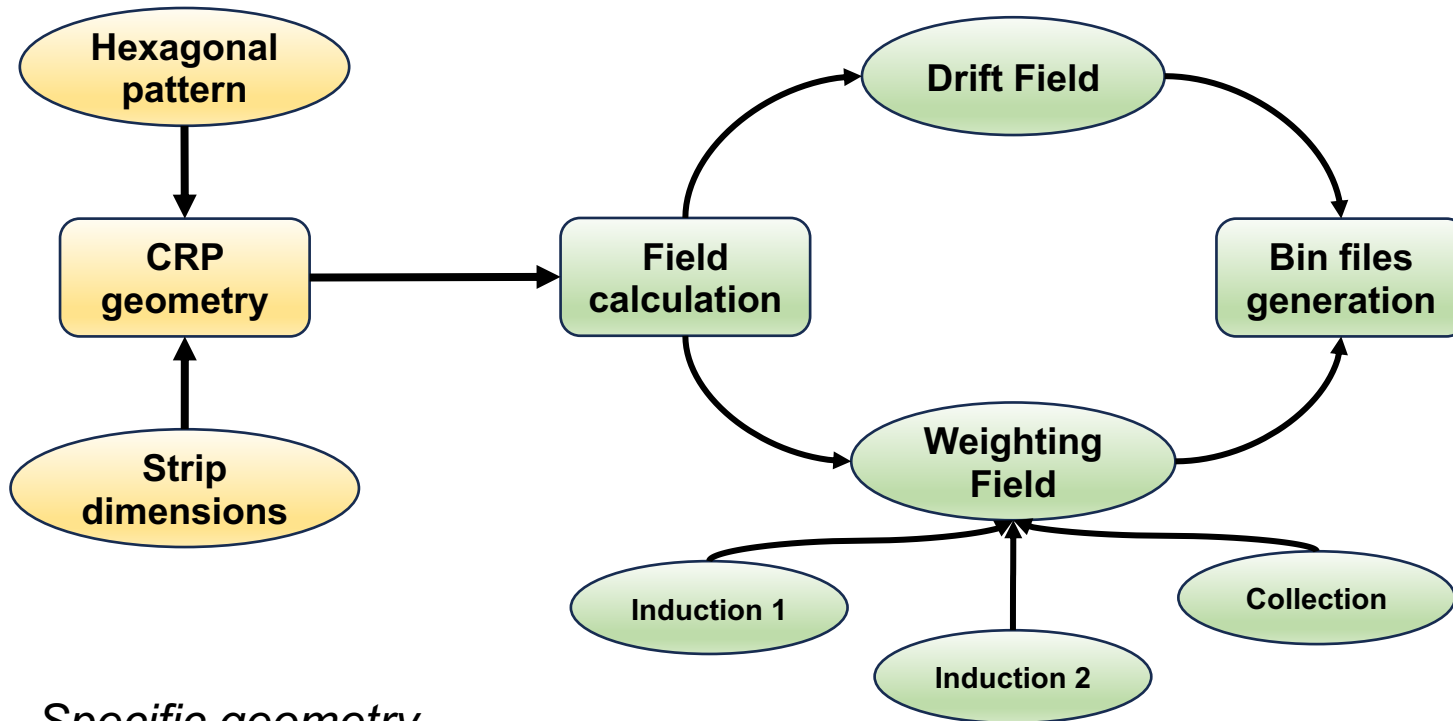


Step used: $50 \mu\text{m}$



Induced signal simulation

- Design of a simulation on Python



1. *Specific geometry setting up*

- Induced signal on the readout strips:

$$i(t) = q \overrightarrow{E}_W \cdot \overrightarrow{v}_D$$

- Weighting field \overrightarrow{E}_W
- Drift Velocity Field:

$$\overrightarrow{v}_D = \mu(|\overrightarrow{E}_D|, T) \times \overrightarrow{E}_D$$

- Solving Laplace's equation in 3D:

$$\Delta\phi(x, y, z) = 0$$

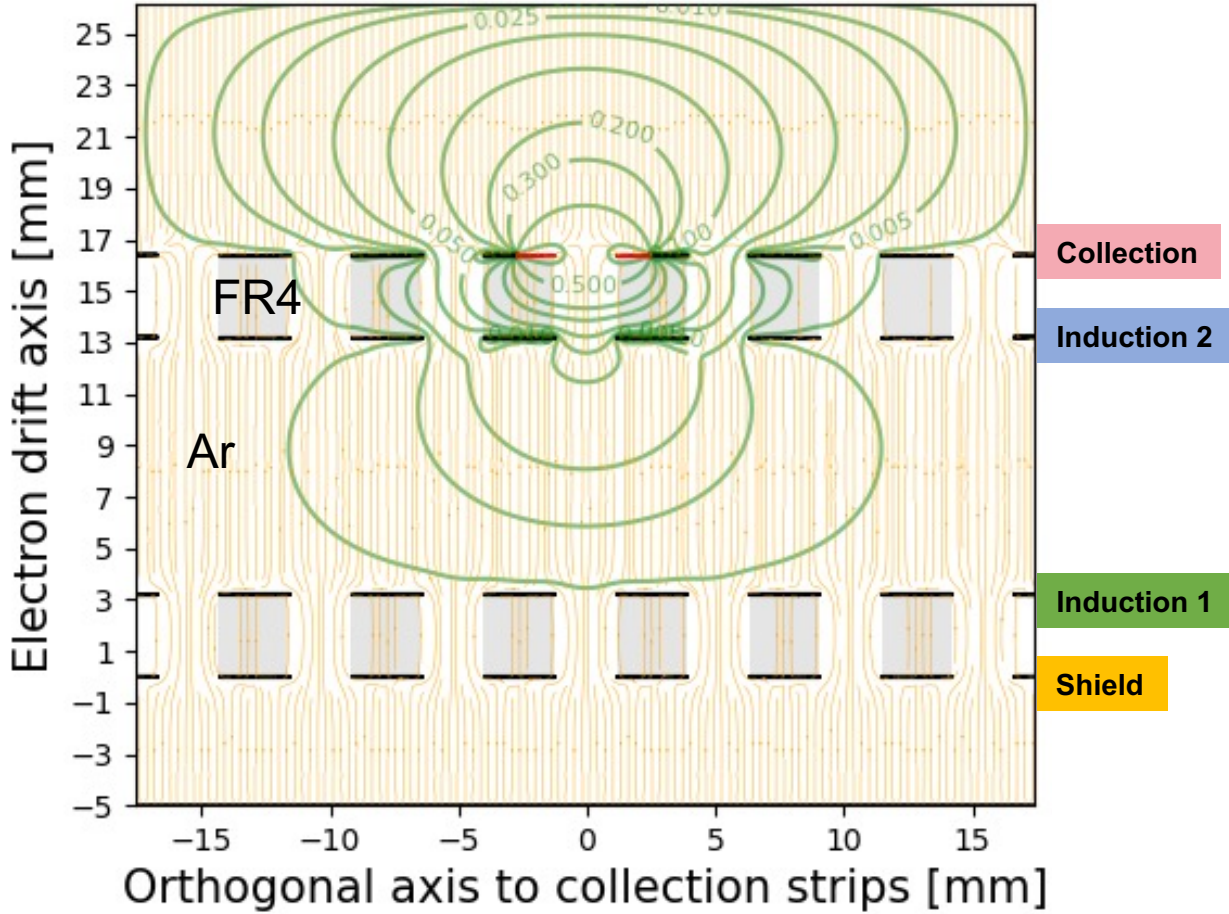
- 3D Finite element method (FEM):

$$\phi_{i,j,k} = \frac{\phi_{i\pm 1,j,k} + \phi_{i,j\pm 1,k} + \phi_{i,j,k\pm 1}}{6}$$

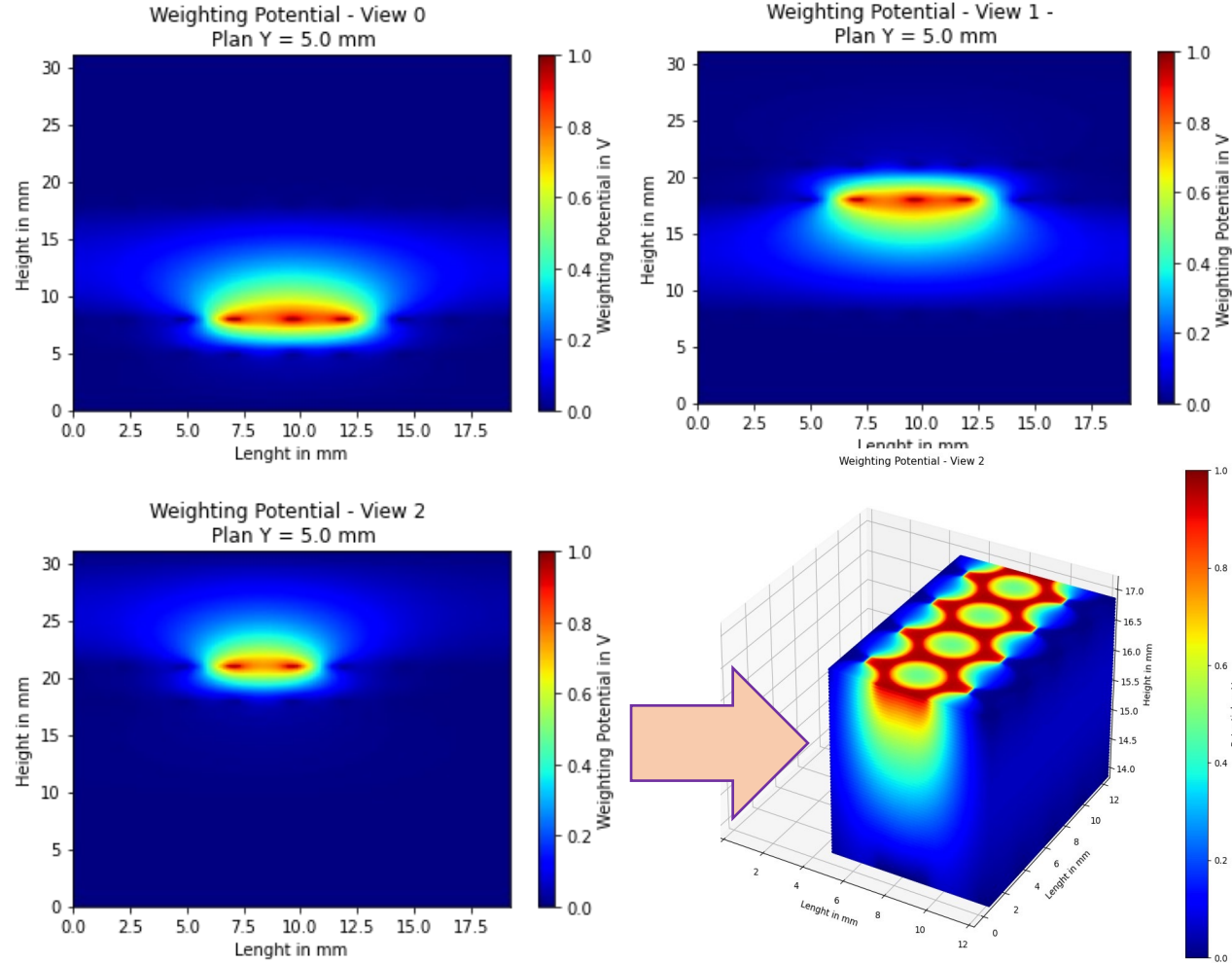
- Iterative method, step by step

Field results

- 2D projection of drift field lines and weighting equipotential



➤ Weighting Potential

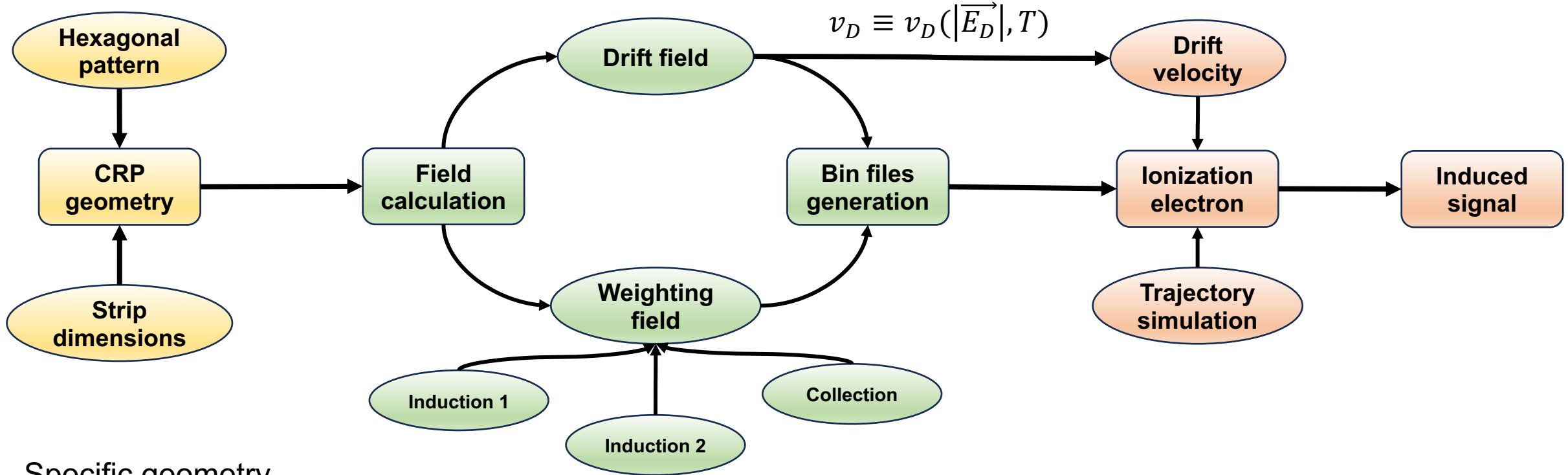


- Induced signal in the nearby strips

Induced signal simulation

➤ Design of a simulation on Python

$$|\vec{E}_D| \in [0.5 ; 4] \text{ kV/cm}$$



$$v_D \equiv v_D(|\vec{E}_D|, T)$$

1. Specific geometry setting up

2. Field generation with CRP geometry

Ionization electron generation

- Thermal electron
 - Trajectory follow drift field lines
- The electron trajectory is perfectly defined

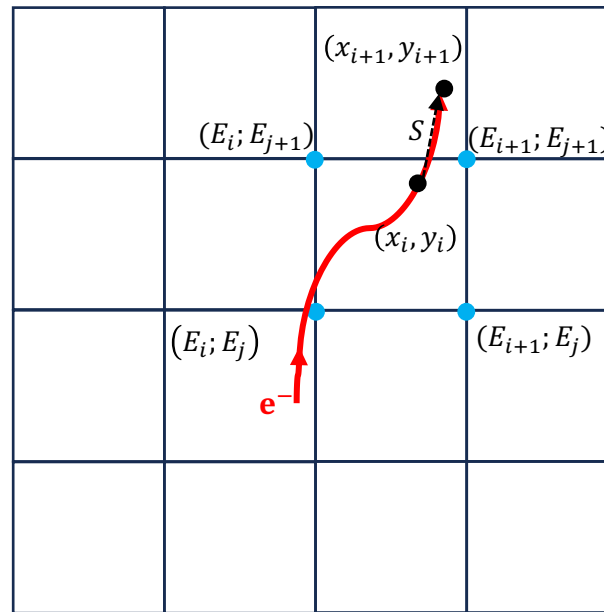
- Runge Kunta like simulation

$$x_{i+1} = x_i + \frac{E_x^{interp}(x_i, y_i)}{|E(x_i, y_i)|} \times S$$

$$y_{i+1} = y_i + \frac{E_y^{interp}(x_i, y_i)}{|E(x_i, y_i)|} \times S$$

- E^{interp} : 3D linear interp

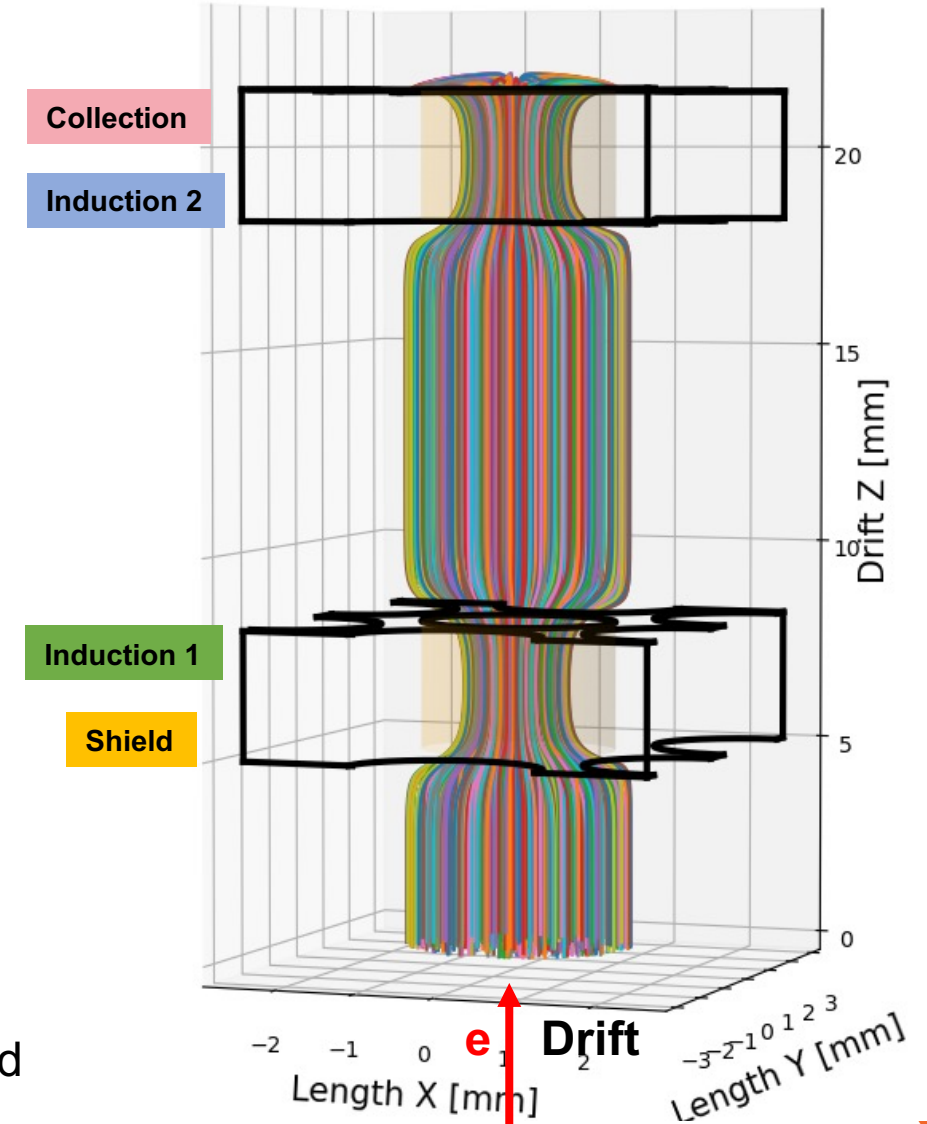
- Drift simulation 5 mm



step = 50 μm

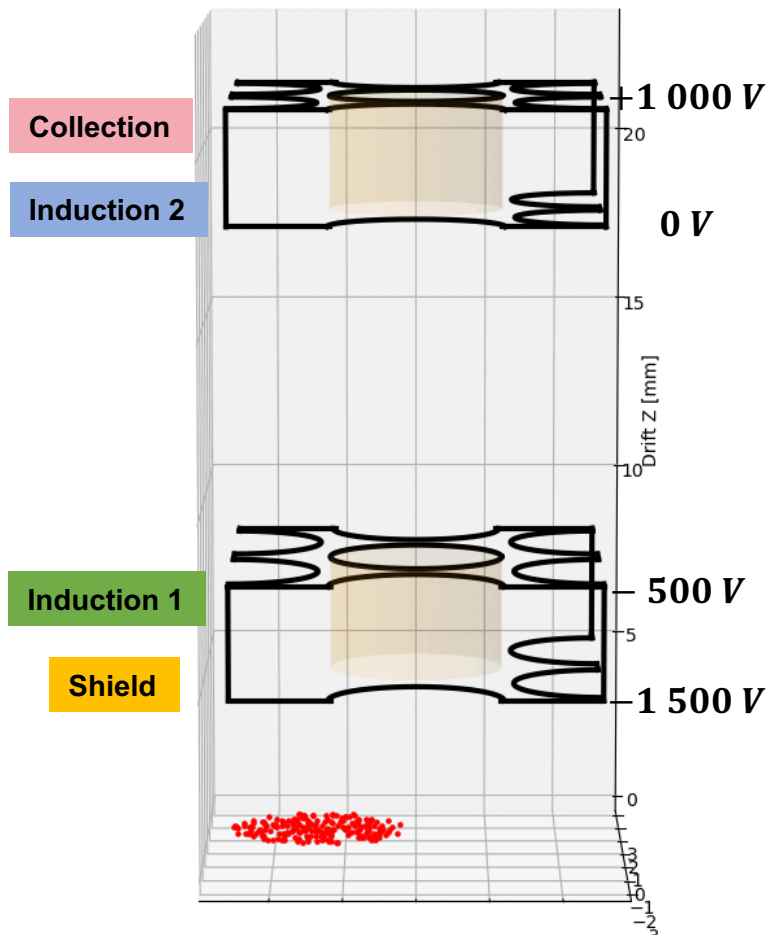
- Grid of the mesh used for the field calculation

- Electron trajectories passing through a CRP's hole

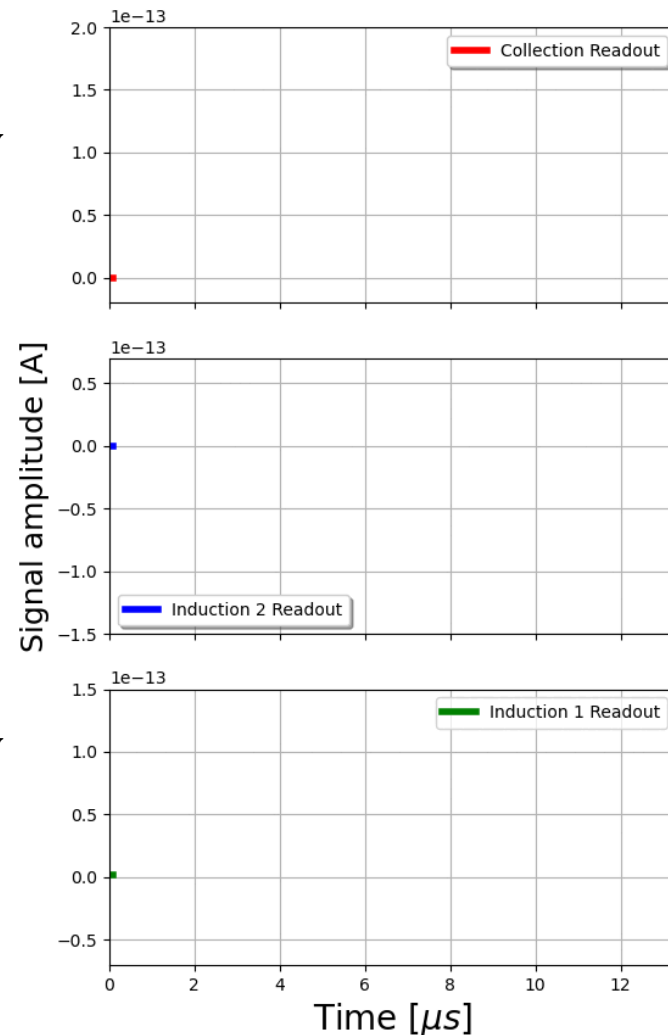


Electron cloud simulation

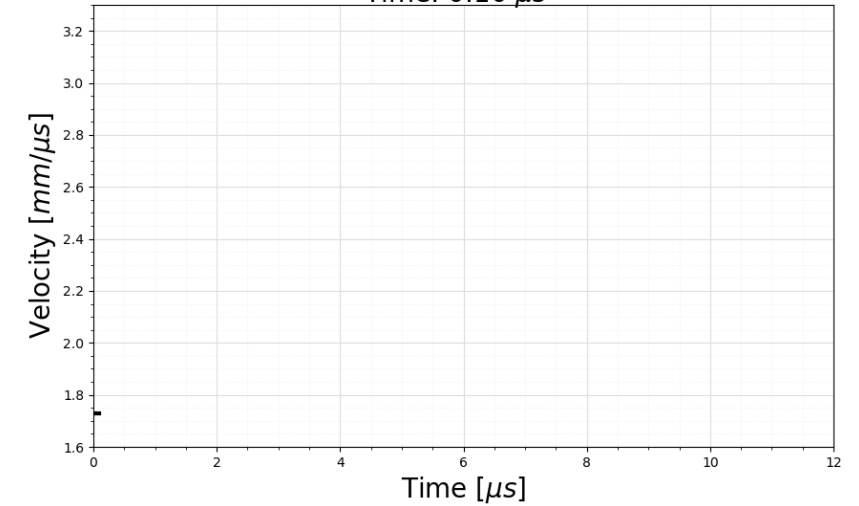
Electron cloud evolution in the anode
Time: $0.10 \mu\text{s}$



Signal on all views
Time: $0.10 \mu\text{s}$

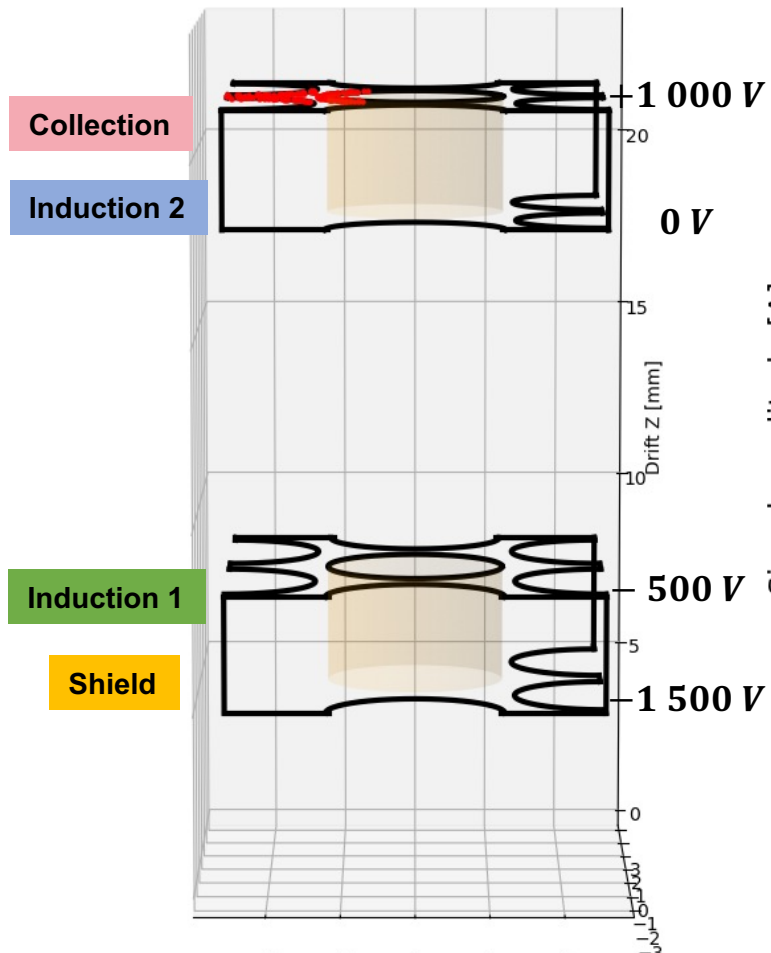


Average of cloud electron drift velocity
Time: $0.10 \mu\text{s}$

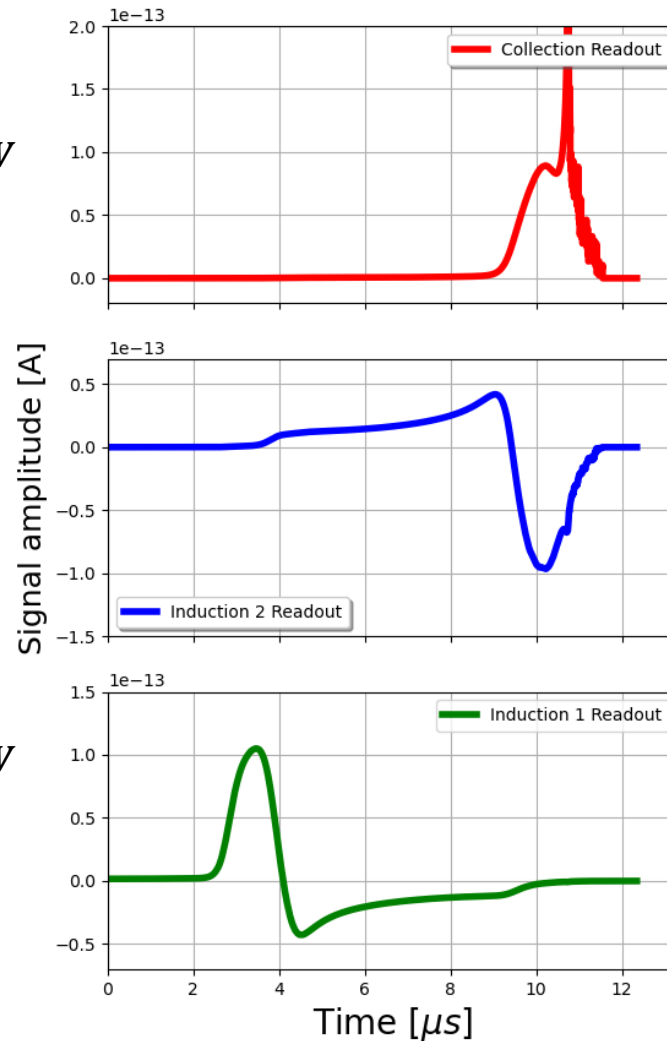


Electron cloud simulation

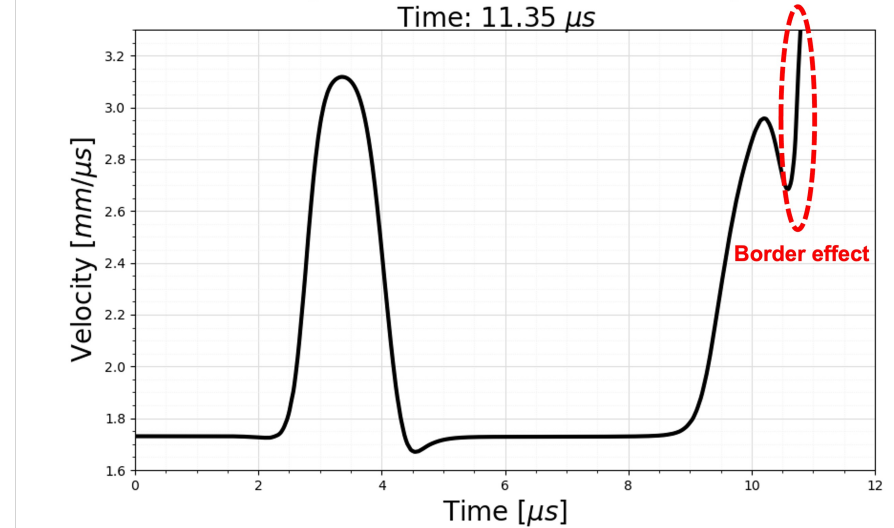
Electron cloud evolution in the anode
Time: 12.35 μs



Signal on all views
Time: 12.35 μs



Average of cloud electron drift velocity
Time: 11.35 μs

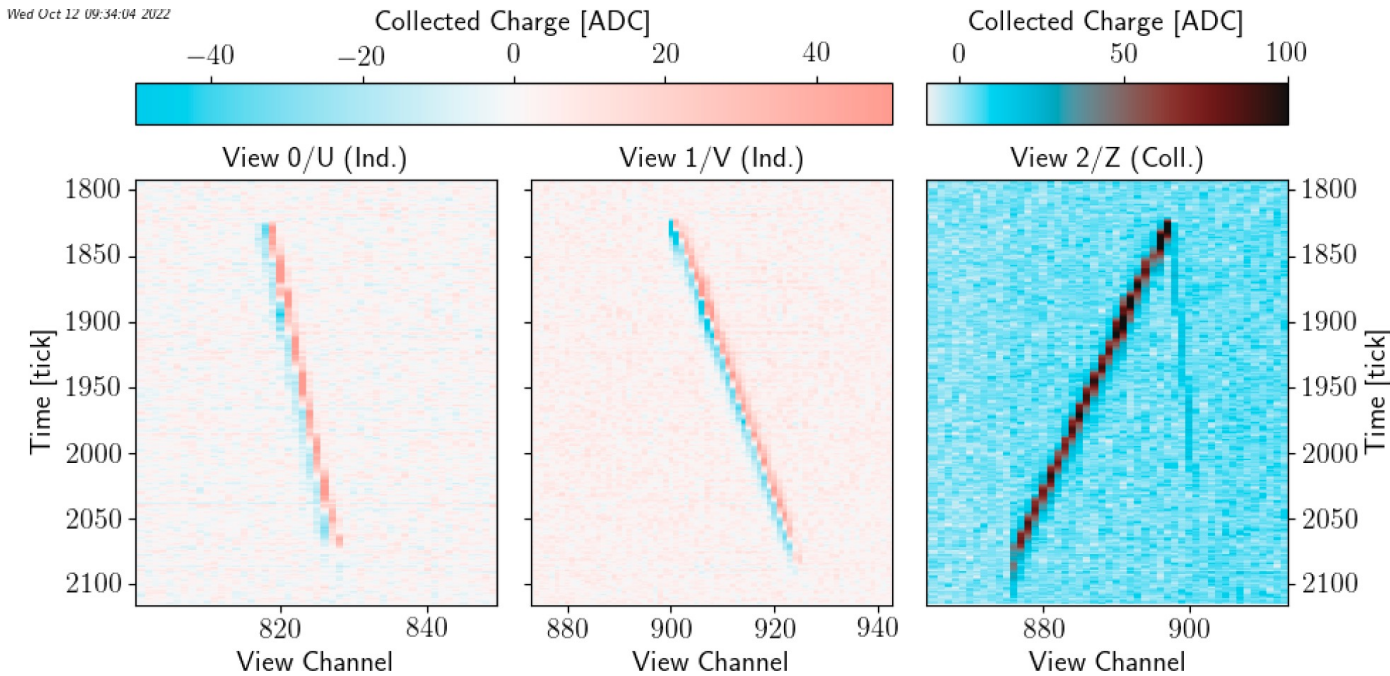
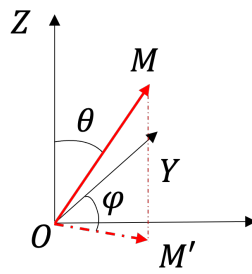


- Border effect near to the collection electrode
- The field takes $\propto 1/r^2$ dependency which will induce a high frequency signal
- Electronic response will smooth the readout induced current

Data extraction

➤ Event Display

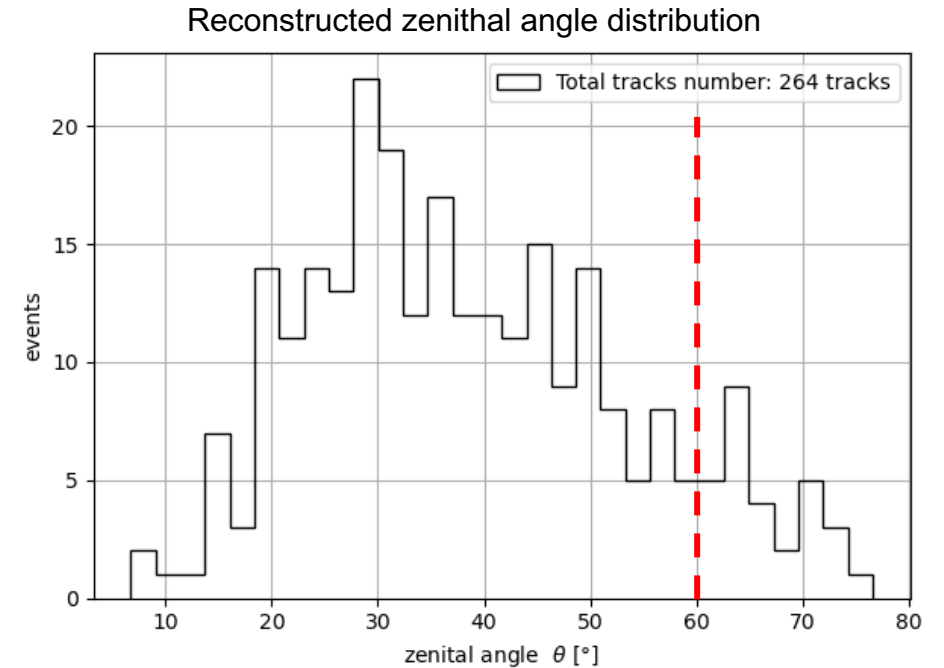
- An example of cosmic ray track from the Coldbox



- Bipolar signals induction view
- Muon events

➤ Coldbox's data cuts

- Tracks with reconstructed angle $\theta > 60^\circ$
- φ in the cone with 45° from the strip readout
- Track lengths $> 20 \text{ cm}$

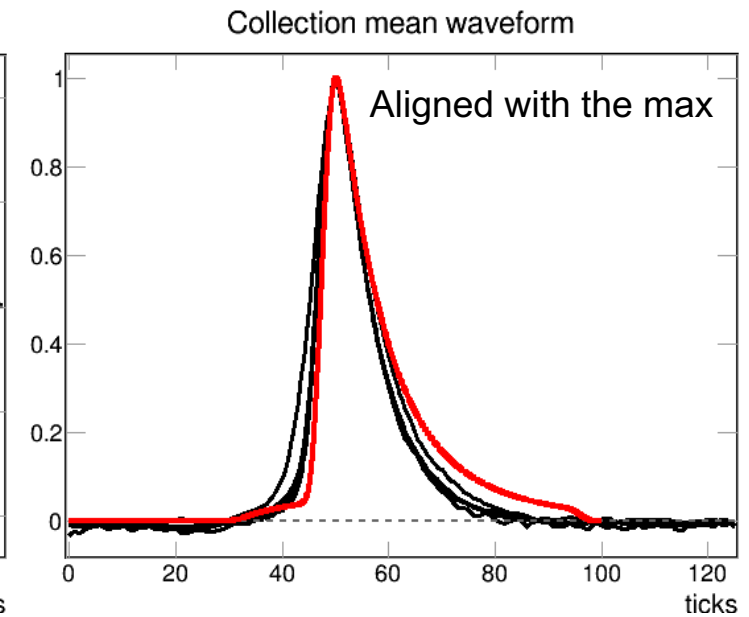
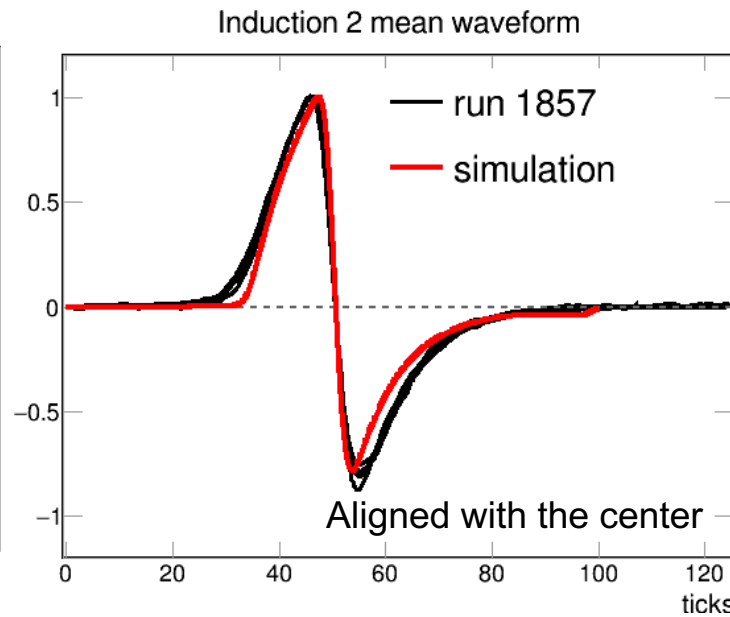
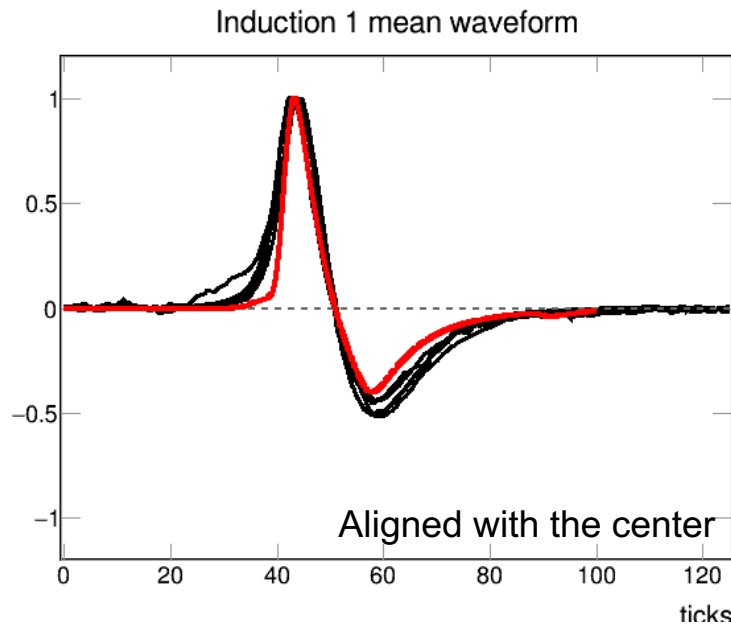
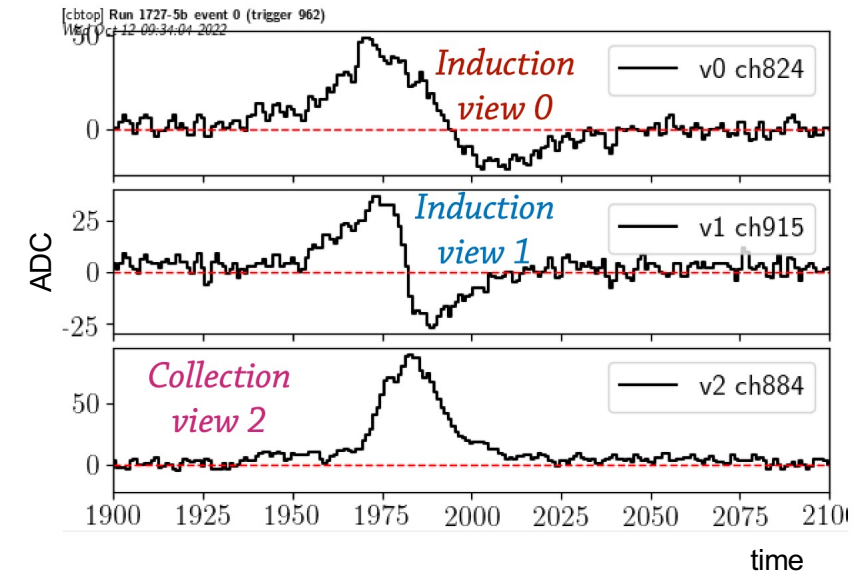


- Data reconstruction with LARDON (software developed by L. Zambelli)
- **Select horizontal track to compare with simulation**

Comparison data VS simulation

➤ Mean waveform

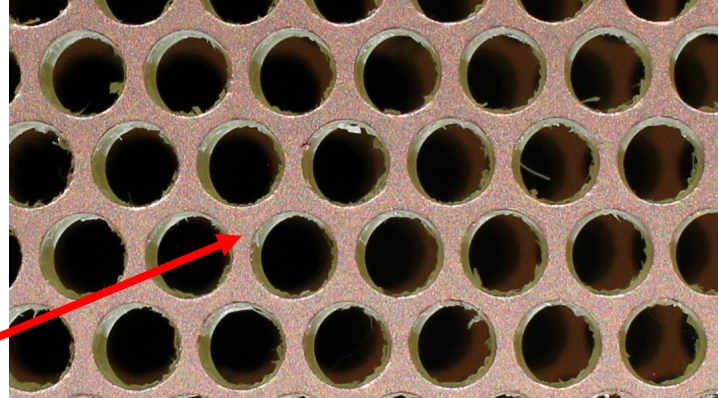
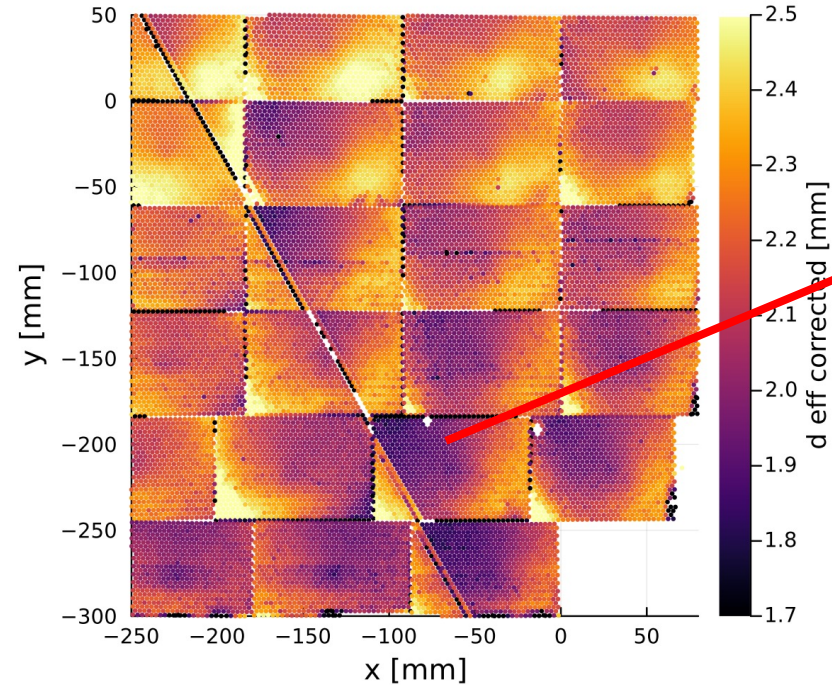
- Signals summation on each readout channel
→ To reduce the incoherent noise
- Mean signal calculation for each track



→ Simulated waveforms in agreement with data

CRP 6 data explanation

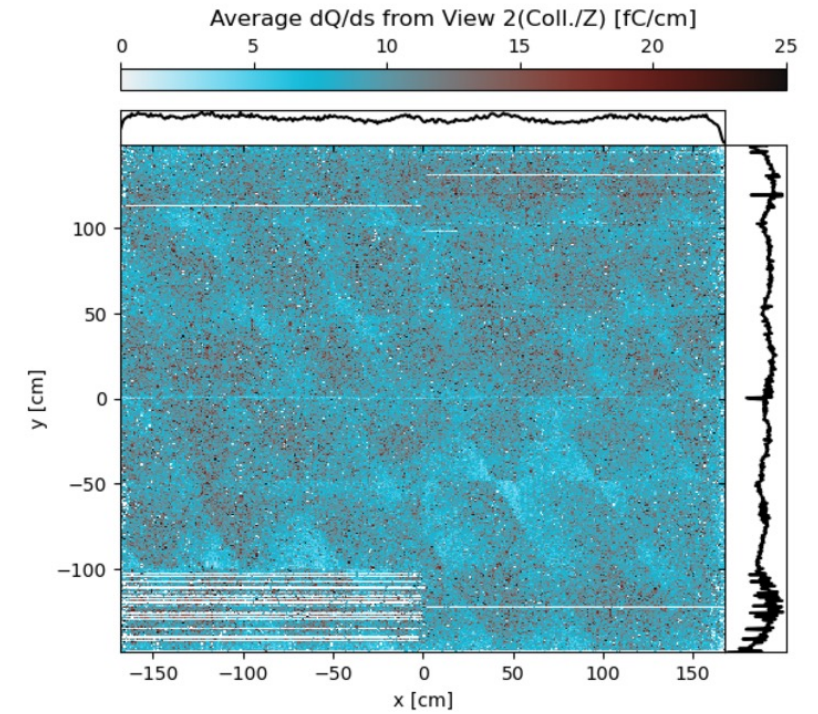
Luis' work*



- Effective hole diameter modified
- PCB shifted between shielding and view 0
- Probably glue inside the holes

Problem: no charge lost in the simulation and no “charging-up” effect

Laura's work**



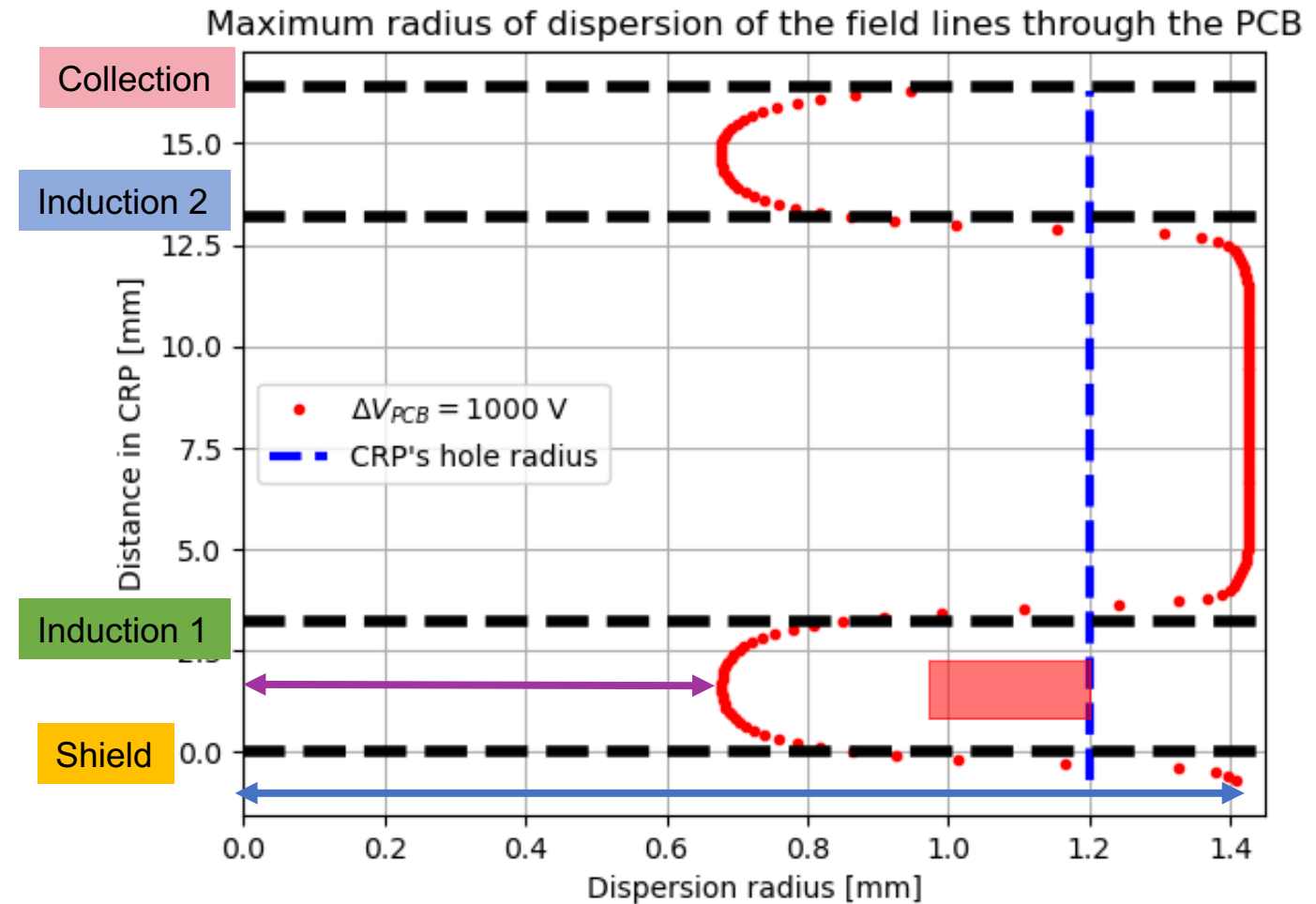
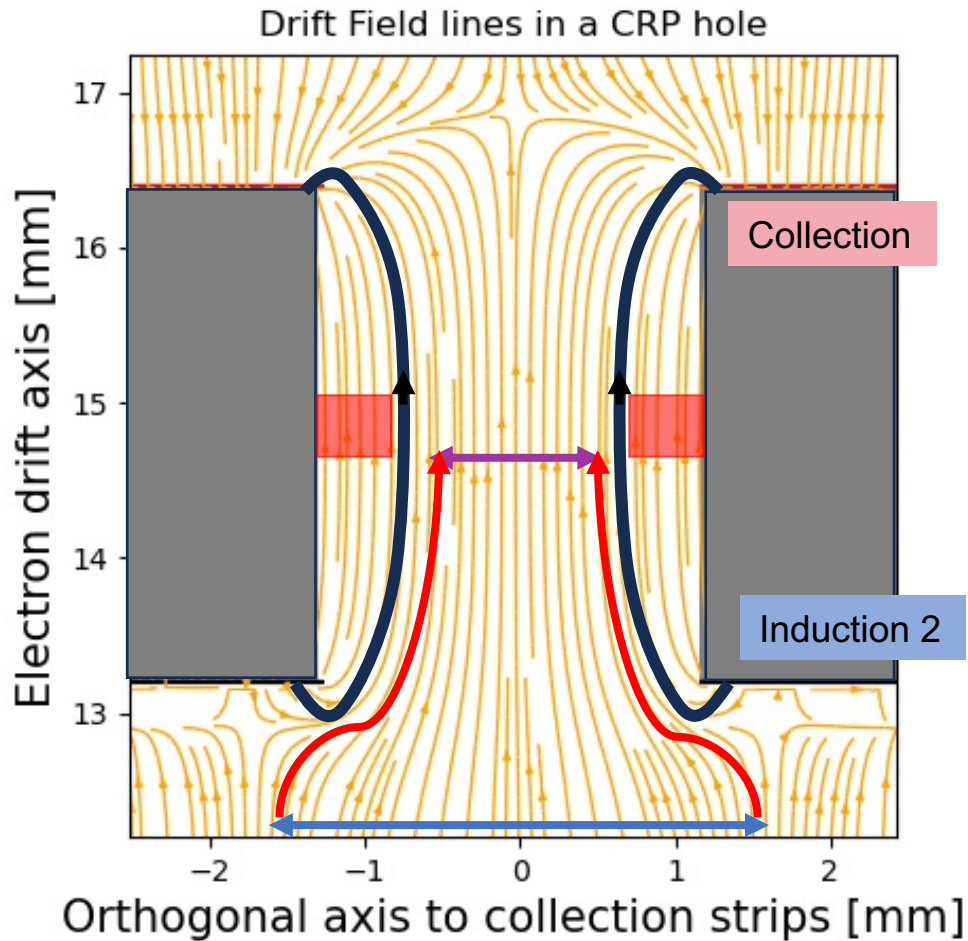
- Consequences: charge lost
- Draw a pattern along the induction strips
- An effect that would seem to be a “charging-up”

* Photo analysis for QA/QC of CRP anodes – Luis Manzanillas

** https://indico.fnal.gov/event/64225/contributions/288494/attachments/176651/240155/cb_crp6_iii_first_look.pdf

Holes covering and loss charge

- Focalization of drift field lines in the CRP hole



- Field line too focused to explain the loss of charge
→ **Electron diffusion**

Electron diffusion

- Transverse electron diffusion could cause a loss of charge in the CRP

$$\frac{\partial n}{\partial t} = D_L \frac{\partial^2 n}{\partial z^2} + D_T \left(\frac{\partial^2 n}{\partial x^2} + \frac{\partial^2 n}{\partial y^2} \right) \quad \text{Fick's equation}$$

- Gaussian spatial distribution of the electrons over time
- Average diffusion length given by:

$$\sigma_{L,T} = \sqrt{2D_{L,T}t}$$

- Longitudinal and transverse diffusion coefficient:

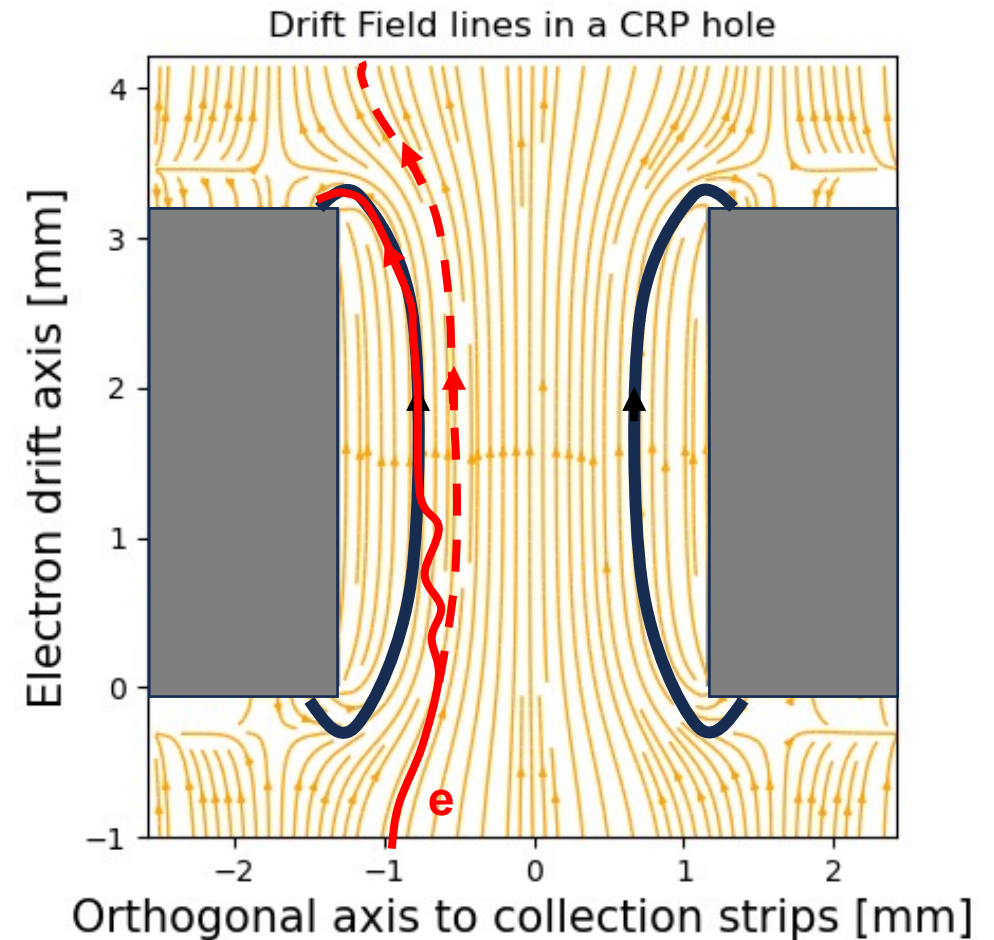
(Einstein's relation) $D_L = \frac{\epsilon_L \mu}{e}$

ϵ_L : longitudinal effective electron energy
 μ : electron mobility

$$\frac{D_L}{D_T} = 1 + \frac{E}{\mu} \frac{\partial \mu}{\partial E}$$

- For next: only transverse diffusion is used (work in progress)

- Electron loss on view 0 due to the diffusion

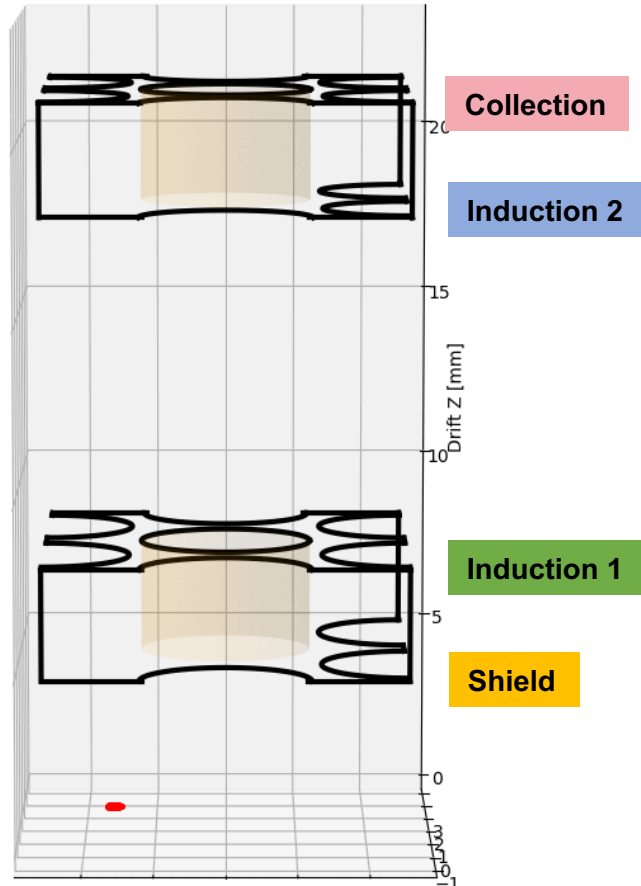
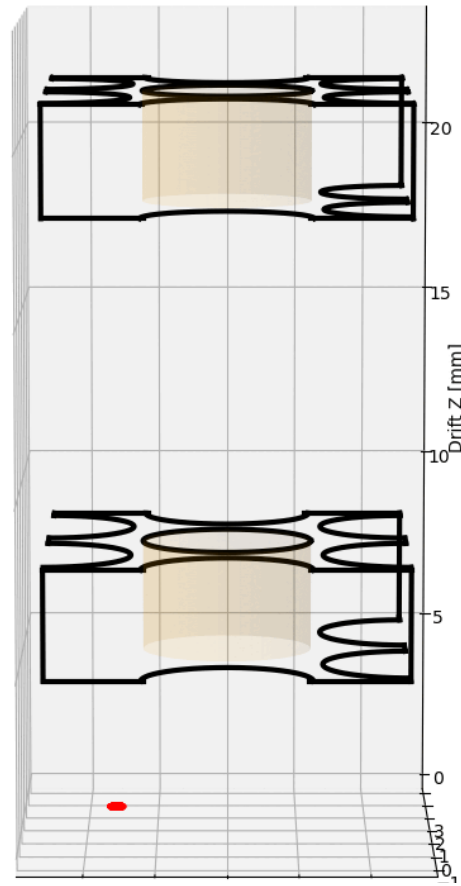


Transverse electron diffusion only

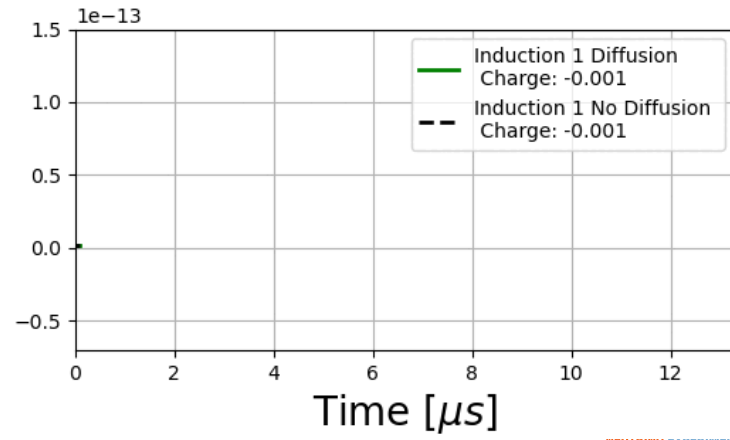
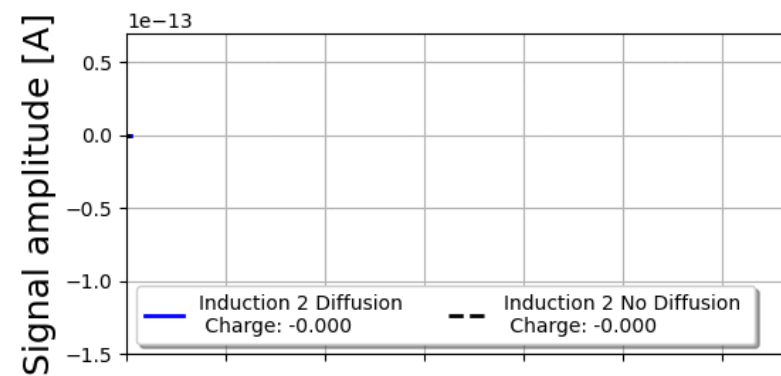
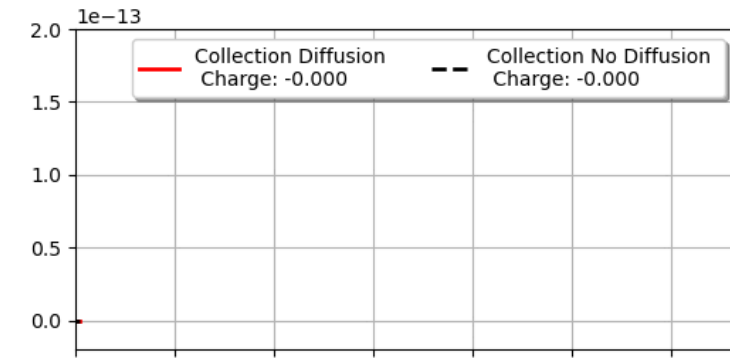
Signal on all views
Time: 0.10 μs

Electron cloud evolution no diffusion
Time: 0.10 μs

Electron cloud evolution with transverse diffusion
Time: 0.10 μs



$D_T = 13.23 \text{ cm}^2/\text{s}^*$



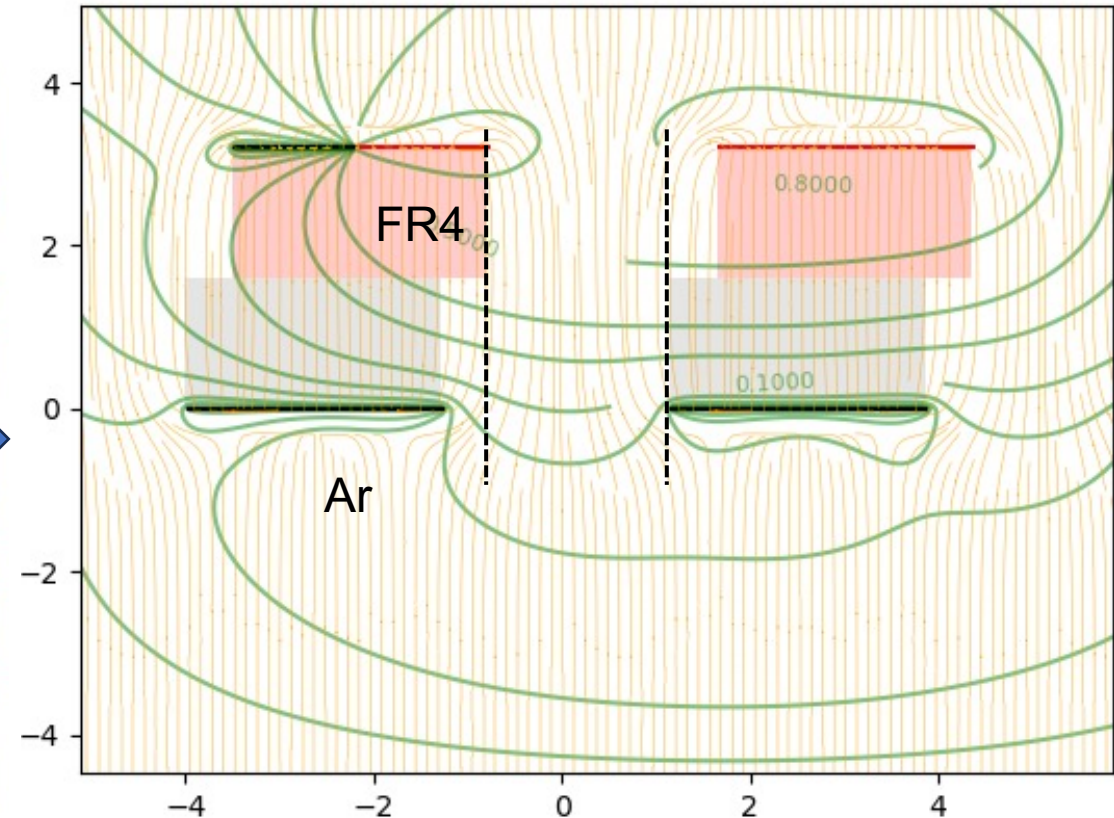
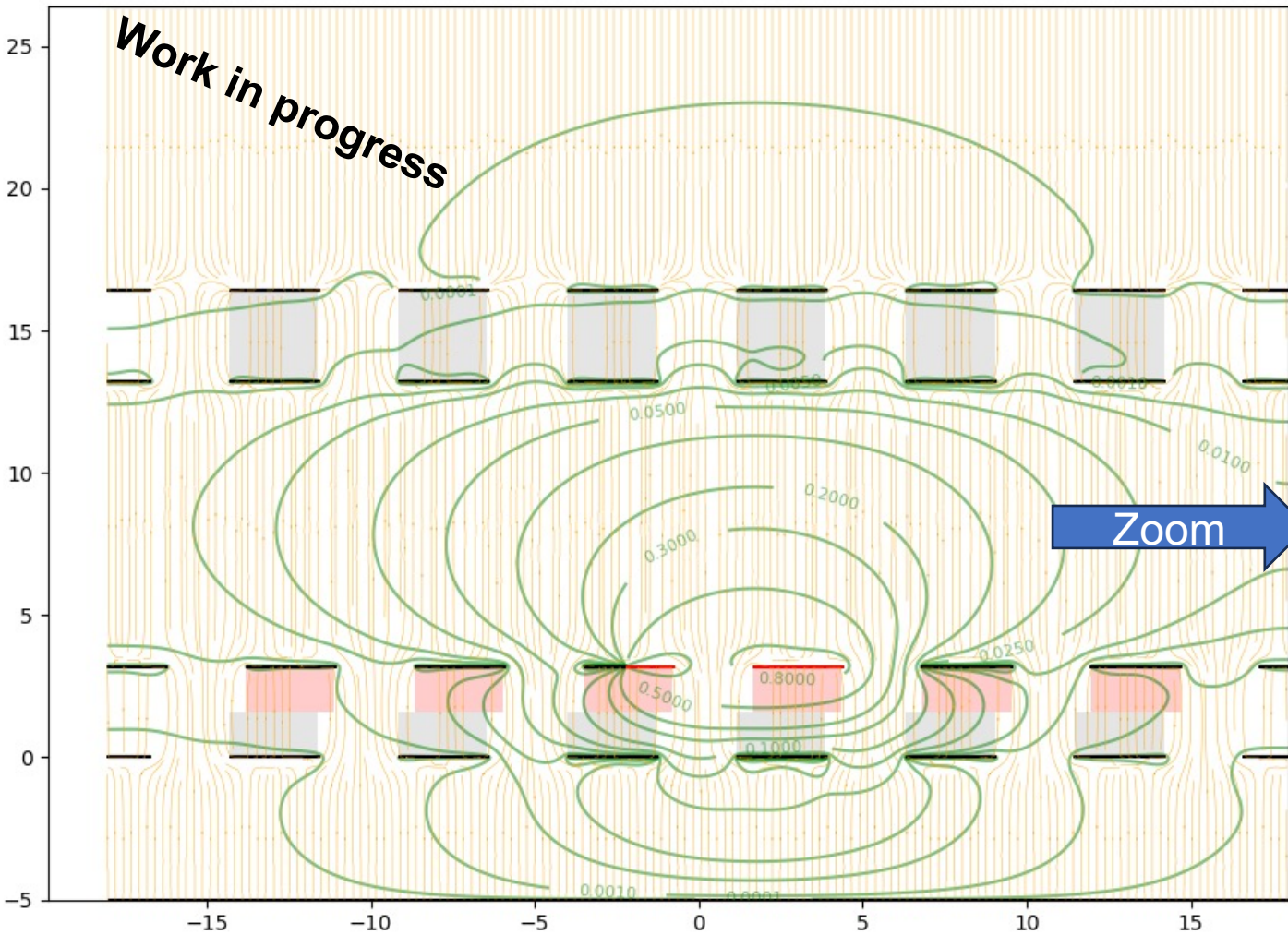
* <https://lar.bnl.gov/properties/trans.html>

Field with hole shifted

- Covering exact area given by:

$$A_{analytic} = 2R^2 \left[\arccos x + 2x\sqrt{1-x^2} \right]$$

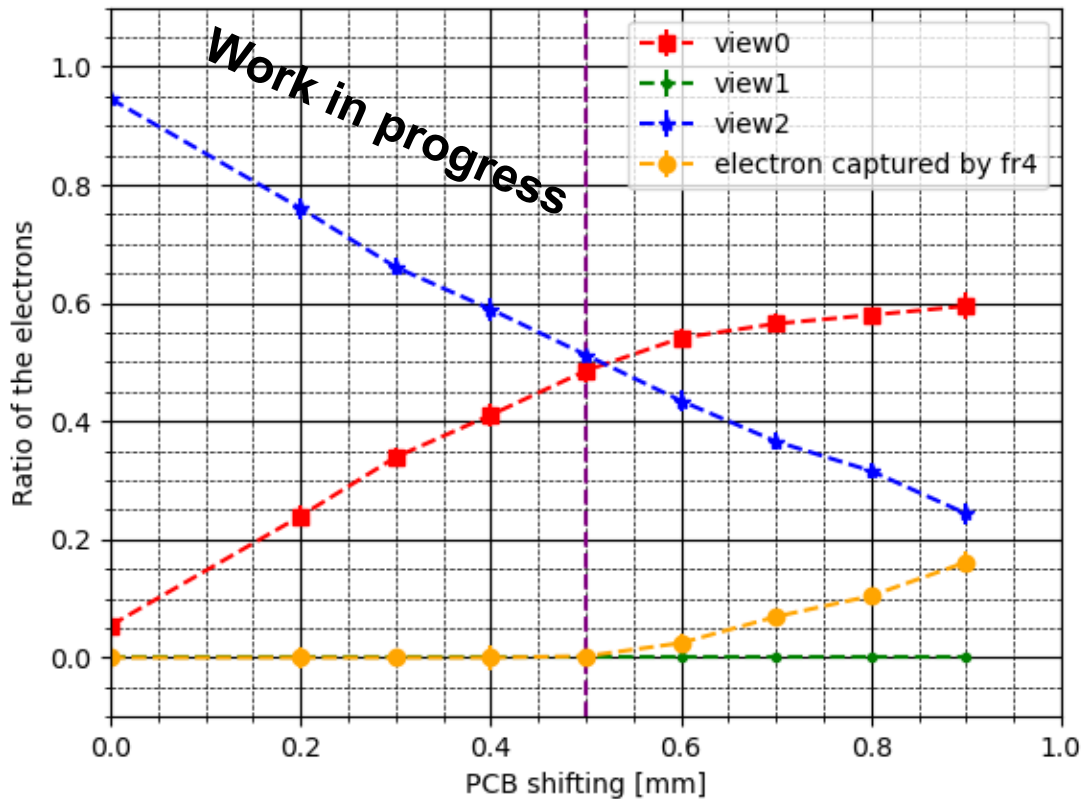
with $x = \frac{\sqrt{R^2 - (x_0/2)^2}}{R}$, x_0 : shifting, $R = 1.2 \text{ mm}$



$x_0 = 0.5 \text{ mm}$
Covering area : 52 %

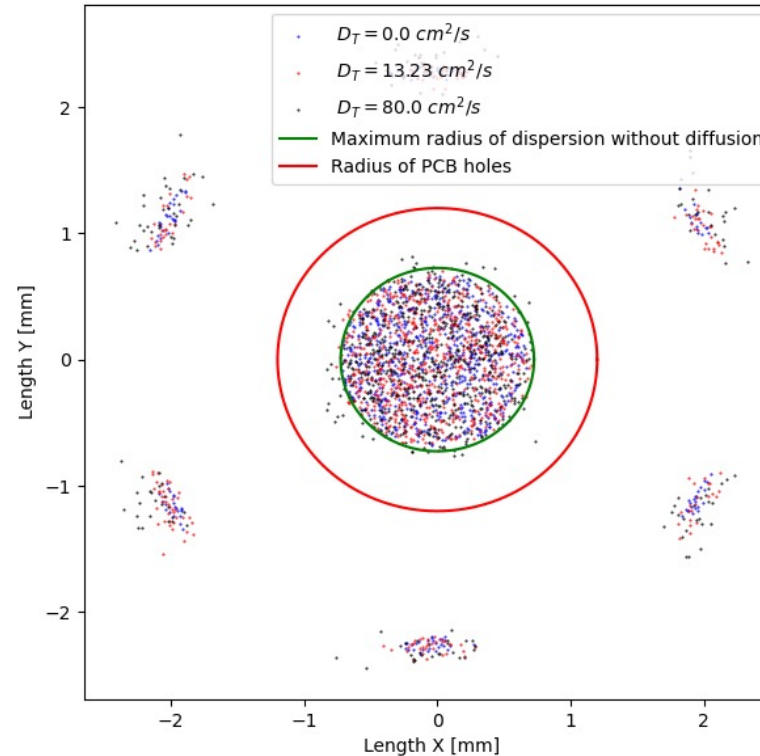
CRP6 transparency (simulation)

Ratio of the electrons collected on the different views and captured by covering the plan

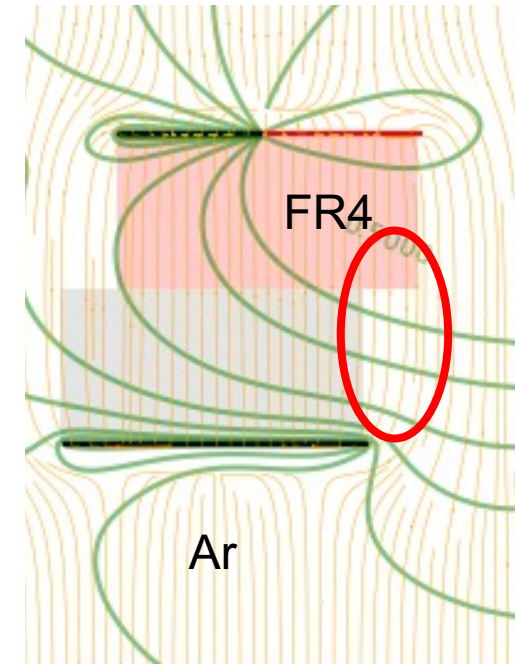


- Increased charge loss
- Charging-up effect can be explain that if the electrons are captured by the FR4.
- i.e. **shifting > 0.5 mm**
- But Luis has measured a shifting max ~ **0.35 mm**

Electrons dispersion through a PCB hole



- Even with diffusion: electron dispersion through a hole is insufficient
- too focused to explain charging-up
→ **Electron diffusion**



→ **Have to implement the dielectric constant for the FR4**

Summary

➤ Work done:

- Numerical simulation conception to understand the formation of induction signals of all views
- Coldbox's data extraction → **simulation is good agreement with this**

➤ What's next ?

- Keep working on the electron diffusion and the impact on the loss charge
 - Same study with longitudinal diffusion
 - Implement the drift field dependance → $D_L(\vec{E}_D, T)$, $D_T(\vec{E}_D, T)$
- Implement the dielectric matrix to discriminate the change of medium (FR4 into Ar and vice versa)
 - Solving Generalized Poisson's equation in 3D:

$$\vec{\nabla} \cdot (\epsilon_r (\vec{\nabla} \phi(x, y, z))) = 0 \text{ (no source)}$$

- Extend the simulation in a bigger volume → track angle studies and position in the TPC (boundary conditions)